

ECEN474: (Analog) VLSI Circuit Design

Fall 2011

Lecture 17: Two Stage Miller OTA

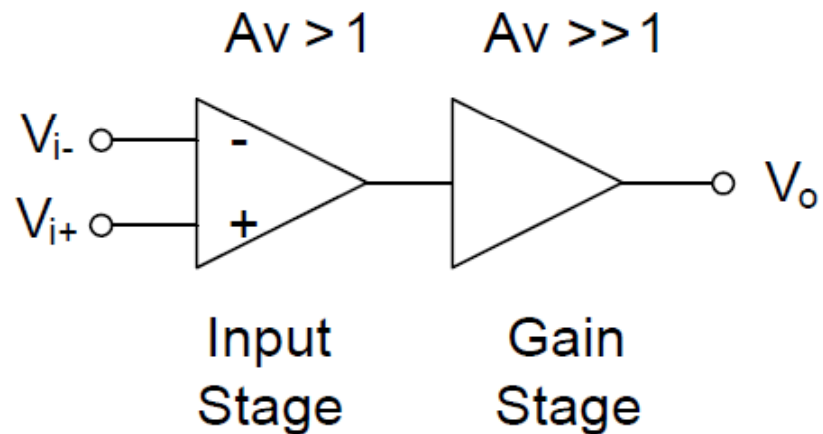


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Agenda

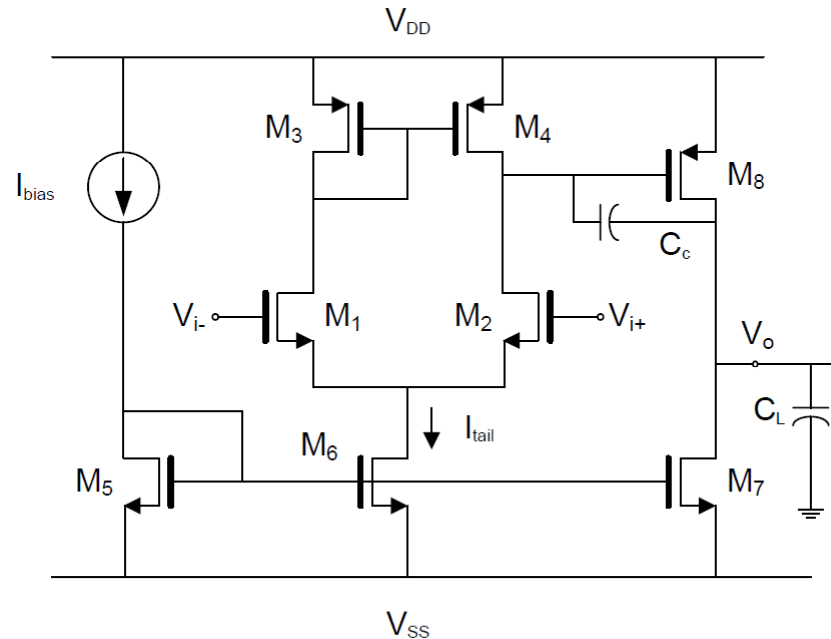
- Two Stage Miller OTA
- OpAmp Characterization

Multi-Stage Amplifiers



- Single-stage amplifiers typically have to trade-off gain and swing range
- Multi-stage amplifiers allow for higher gain without sacrificing swing range
- The major challenge with multi-stage amplifiers is achieving adequate phase margin to insure stability in a feedback configuration

Two Stage Miller OTA

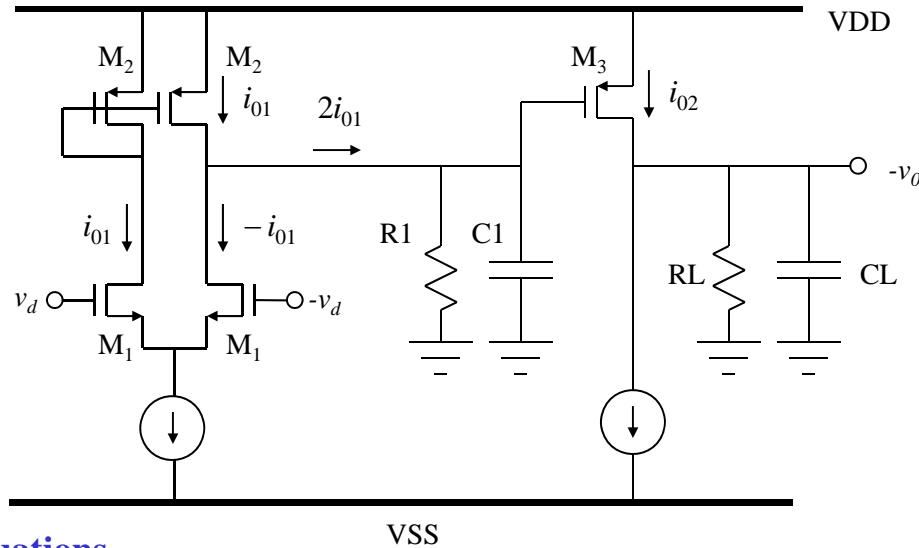


$$\text{DC Gain } A_{VDC} = A_{v1}A_{v2} = \left(-\frac{g_{m2}}{g_{o2} + g_{o4}} \right) \left(-\frac{g_{m8}}{g_{o8} + g_{o7}} \right) = \frac{g_{m2}g_{m8}}{(g_{o2} + g_{o4})(g_{o8} + g_{o7})}$$

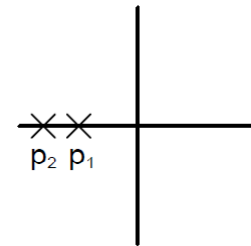
$$A_{VDC} = G_m R_{out}$$

$$R_{out} = \frac{1}{g_{o8} + g_{o7}}$$

$$G_m = -g_{m8}A_{v1} = \frac{g_{m8}g_{m2}}{g_{o2} + g_{o4}}$$



$$A(s) = \frac{A_{VDC}}{\left(1 + \frac{s}{\omega_{p1}}\right) \left(1 + \frac{s}{\omega_{p2}}\right)}$$



↓ Main equations

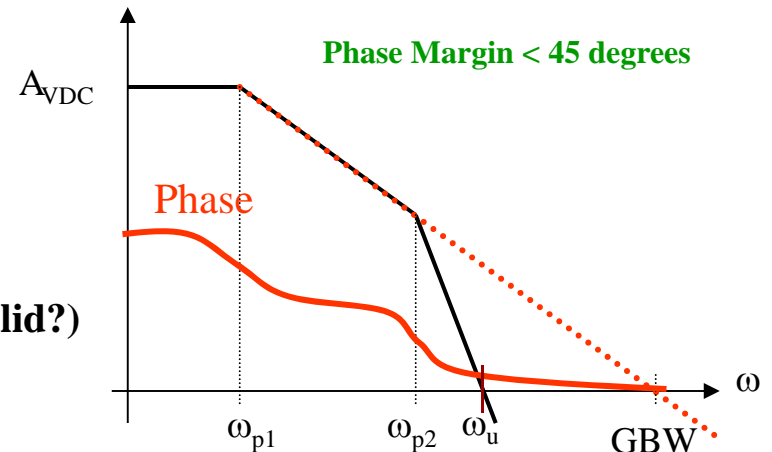
$$A_{VDC} = -\frac{g_{m1} g_{m3}}{g_1 g_L}$$

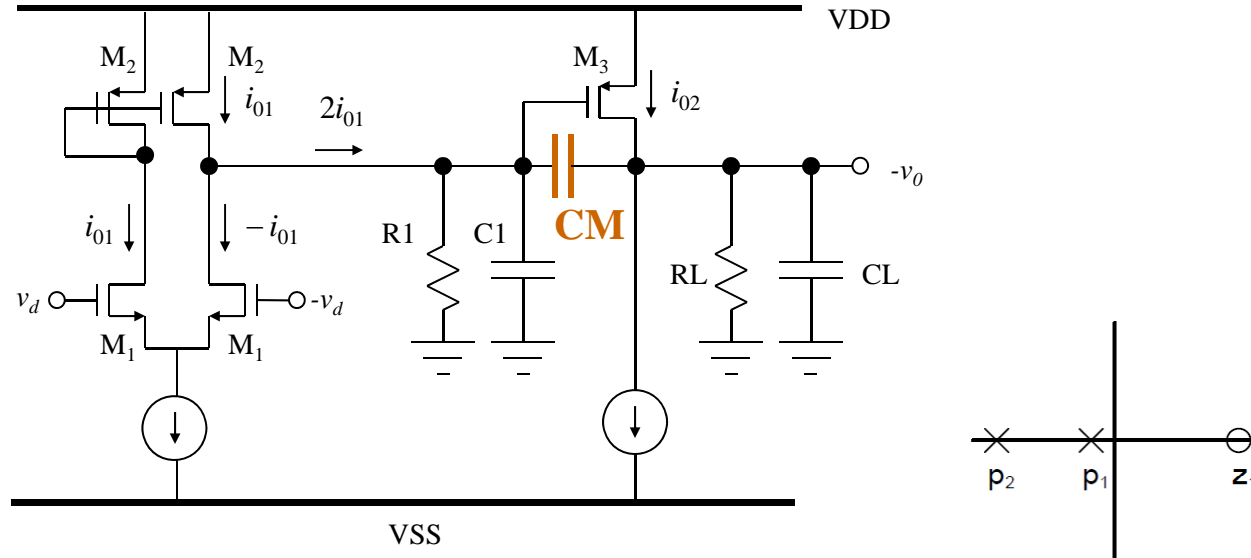
$$\omega_{p1} = -\frac{g_1}{C_1} \text{ (LHP)}$$

$$\omega_{p2} = -\frac{g_L}{C_L} \text{ (LHP)}$$

$$GBW = (A_{VDC}) * (\min(\omega_{p1}, \omega_{p2})) \text{ (if dominant pole system, valid?)}$$

$$Phase_margin = 180 - \tan^{-1}\left(\frac{\omega_u}{\omega_{p1}}\right) - \tan^{-1}\left(\frac{\omega_u}{\omega_{p2}}\right)$$





$$A_{VDC} = -\frac{g_{m1} g_{m3}}{g_1 g_L}$$

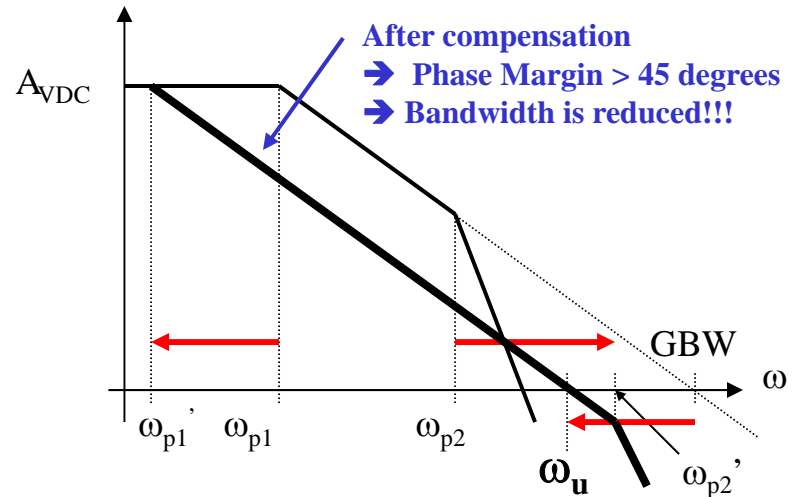
Phase compensation → Pole splitting techniques!!

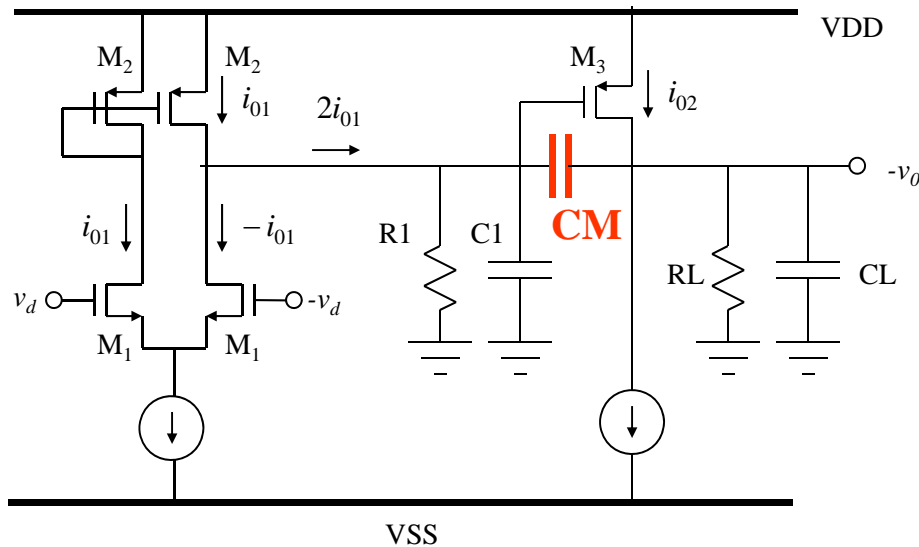
$$\omega_{p1} = -\frac{g_1}{C_1 + \frac{g_{m3}}{g_L} C_M} \quad \text{(LHP)}$$

$$\omega_{p2} = -\frac{g_{m3}}{C_1 + C_L} \quad \text{(LHP)}$$

$$GBW' = (A_{VDC}) * |\omega_{p1}| \cong \frac{g_{m1}}{C_M}$$

$$\text{Phase_margin} = 180 - \tan^{-1}\left(\frac{GBW'}{\omega_{p1}}\right) - \tan^{-1}\left(\frac{GBW'}{\omega_{p2}}\right)$$





$$A(s) = \frac{A_{VDC} \left(1 - \frac{s}{\omega_z}\right)}{\left(1 + \frac{s}{\omega_{p1}}\right) \left(1 + \frac{s}{\omega_{p2}}\right)}$$

☞ **Parasitic (bad) RHP zero!!**

$$\omega_{ZERO} = + \frac{g_{m3}}{C_M} \text{ (RHP)}$$

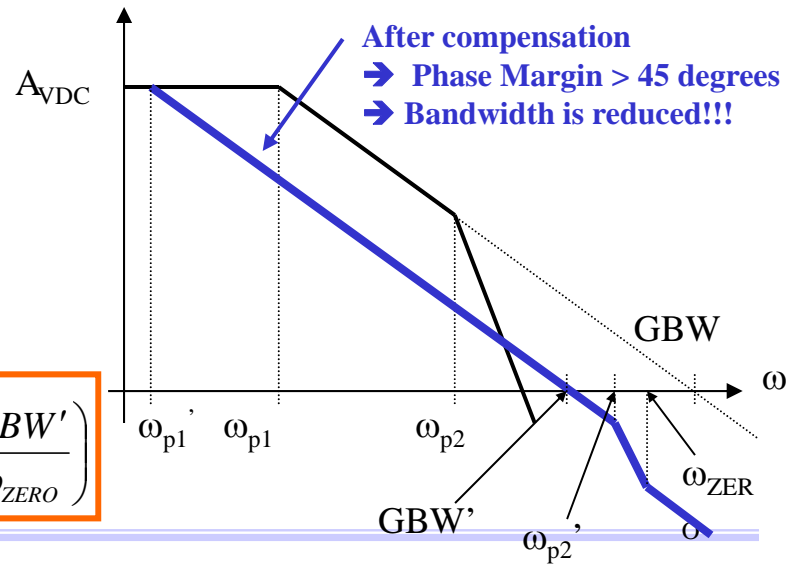
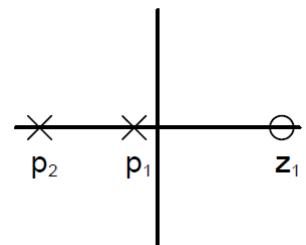
$$A_{VDC} = - \frac{g_{m1} g_{m3}}{g_{1} g_L}$$

$$\omega_{p1} = - \frac{g_1}{C_1 + \frac{g_{m3}}{g_L} C_M} \text{ (LHP)}$$

$$\omega_{p2} = - \frac{g_{m3}}{C_1 + C_L} \text{ (LHP)}$$

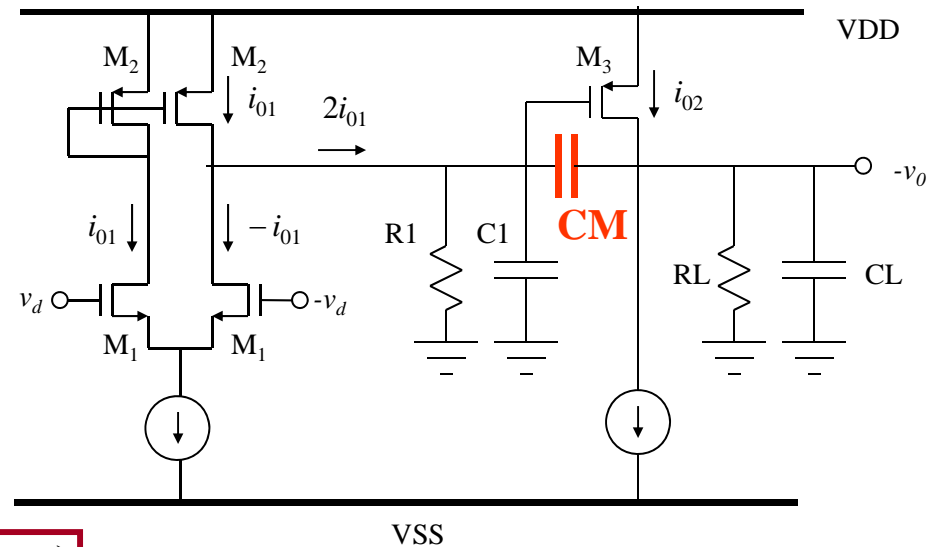
$$GBW' = (A_{VDC}) * |\omega_{p1}| \cong \frac{g_{m1}}{C_M}$$

$$Phase_margin = 180 - \tan^{-1}\left(\frac{GBW'}{\omega_{p1}}\right) - \tan^{-1}\left(\frac{GBW'}{\omega_{p2}}\right) - \tan^{-1}\left(\frac{GBW'}{\omega_{ZERO}}\right)$$



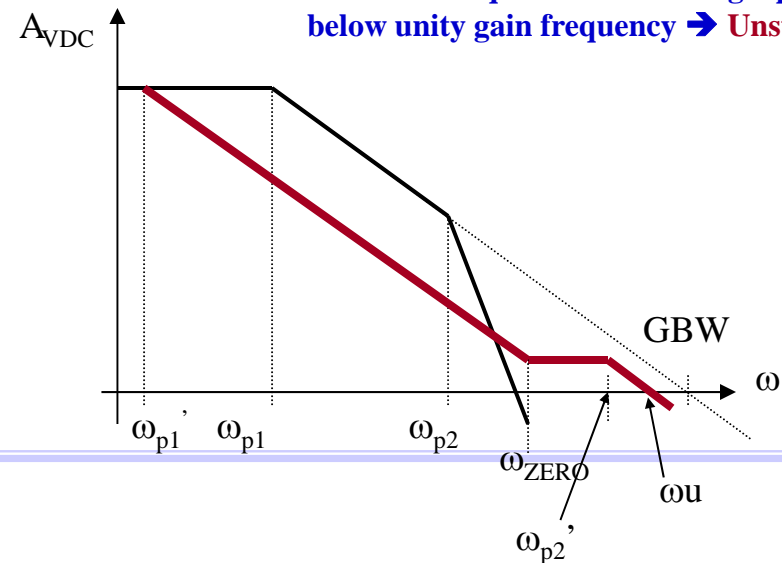
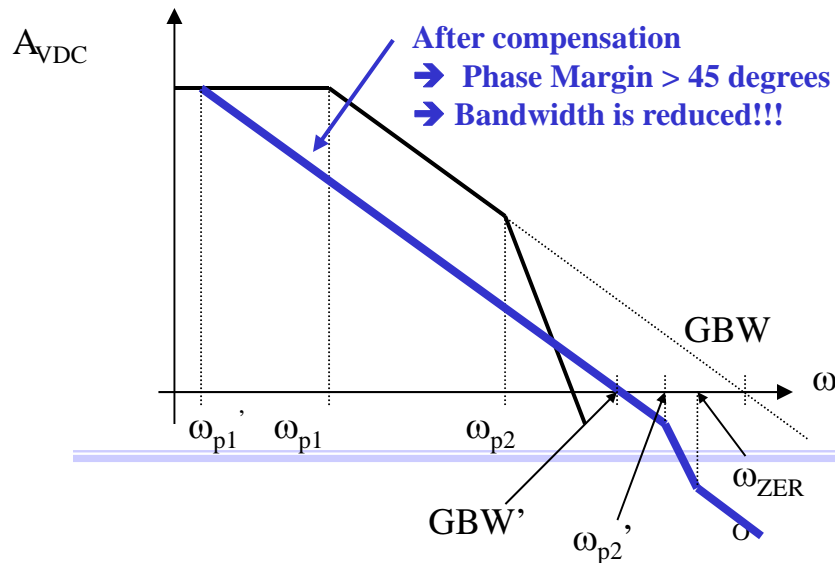
- ☞ **Parasitic (bad) RHP zero!!**
- ☞ **Can be catastrophic if close or below ω_u !**

$$\omega_{ZERO} = \frac{g_{m3}}{C_M}$$

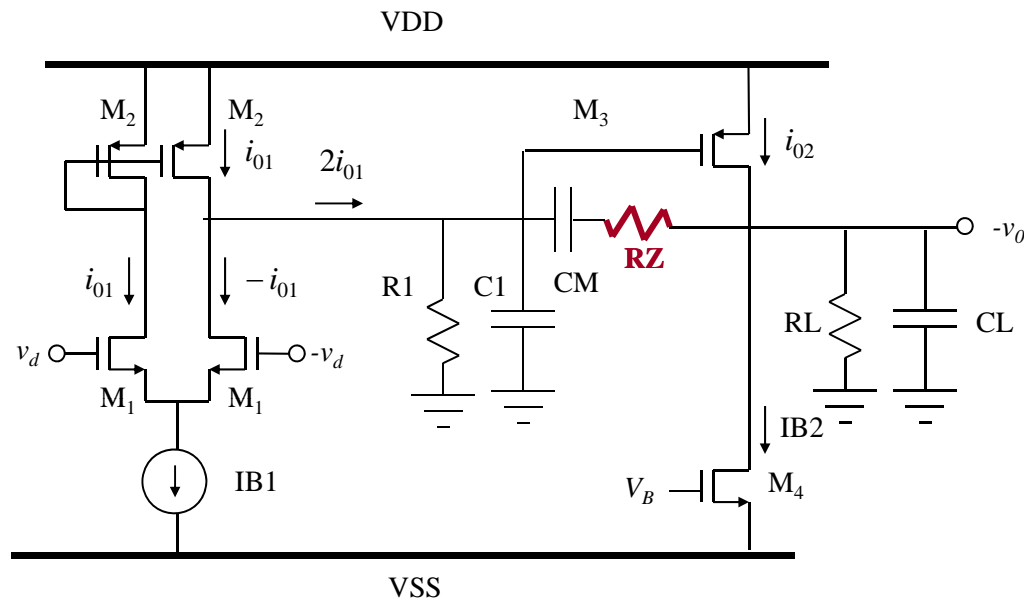


$$\text{Phase_margin} = 180 - \tan^{-1}\left(\frac{\omega_u}{\omega_{p1}'}\right) - \tan^{-1}\left(\frac{\omega_u}{\omega_{p2}'}\right) - \tan^{-1}\left(\frac{\omega_u}{\omega_{ZERO}}\right)$$

- After compensation
- ➔ Phase Margin $\ll 45$ degrees
 - ➔ Phase is equivalent to having 3 poles below unity gain frequency ➔ **Unstable!**



Adding a series resistance



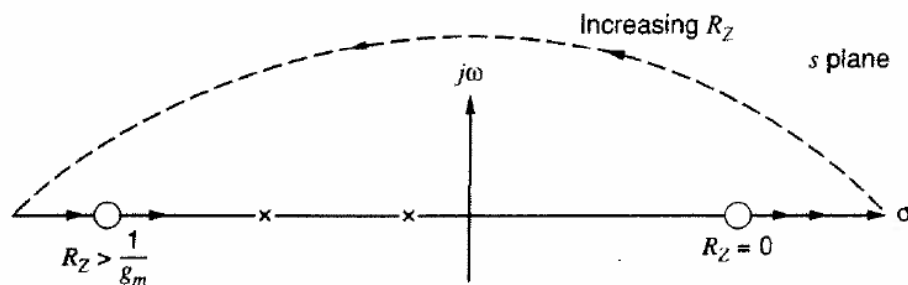
$$A(s) = \frac{A_{VDC} \left(1 - \frac{s}{\omega_z}\right)}{\left(1 + \frac{s}{\omega_{p1}}\right) \left(1 + \frac{s}{\omega_{p2}}\right) \left(1 + \frac{s}{\omega_{p3}}\right)}$$

$$\omega_{p3} \approx -\frac{1}{R_Z C_1} \quad (\text{Generally high frequency \& can be ignored})$$

$$\omega_z = \frac{1}{\left(\frac{1}{g_{m3}} - R_Z\right) C_M}$$

Can design R_Z to improve phase margin

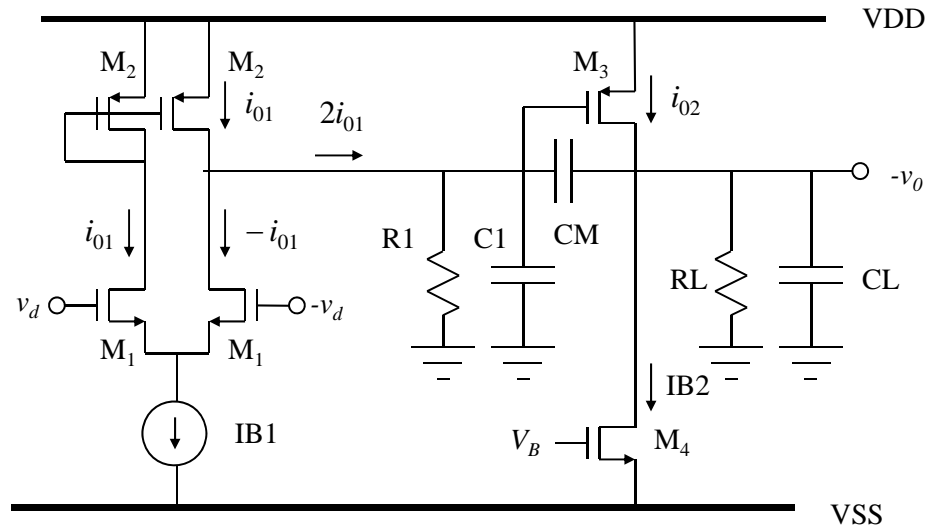
Non - zero R_Z will push RHP to a higher frequency (initially)



$$R_Z = \frac{1}{g_{m3}} \quad \text{pushes the RHP zero to infinity}$$

$$R_Z > \frac{1}{g_{m3}} \quad \text{pushes zero from RHP to LFP}$$

$$R_Z = \frac{C_L + C_M + C_1}{g_{m3} C_M} \quad \text{can cancel } \omega_{p2}$$



↓ Spectral noise density at low frequencies (capacitors are neglected)

$$i_{eq_out}^2 = \frac{8kT}{3} \left[(2g_{m1} + 2g_{m2}) \left(\frac{g_{m3}}{g_1} \right)^2 + g_{m3} + g_{m4} \right]$$

Output referred current noise density

$$v_{eq_in}^2 = \frac{i_{eq_out}^2}{\left(\frac{g_{m1}g_{m3}}{g_1} \right)^2} = \frac{8kT}{3g_{m1}} \left[2 + 2\frac{g_{m2}}{g_{m1}} + \frac{g_{m3} + g_{m4}}{g_{m1} \left(\frac{g_{m3}}{g_1} \right)^2} \right]$$

Input referred voltage noise density

OPAMP Characterization

Main parameters to be measured:

- DC gain (10^4 - 10^6 V/V)
- Frequency Limitations
 - Bandwith (Few Hertz~1kHz)
 - Gain-Bandwidth product (1~100 Mhz)
- Output resistance
- Input Impedance
- Signal Swing
 - Common-mode input range
 - Output swing
- Stability
- DC Offset
- Slew-rate
- CMRR
- PSRR

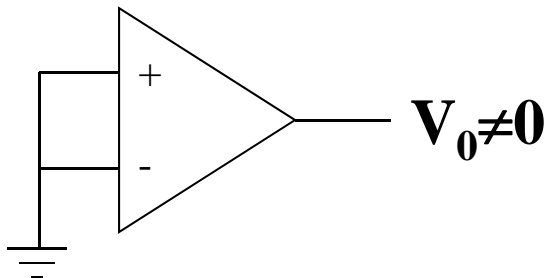
For this section, see:

**CMOS Analog design, Allen & Holberg
2nd edition, HPR, 2002.**

OPAMP Characterization

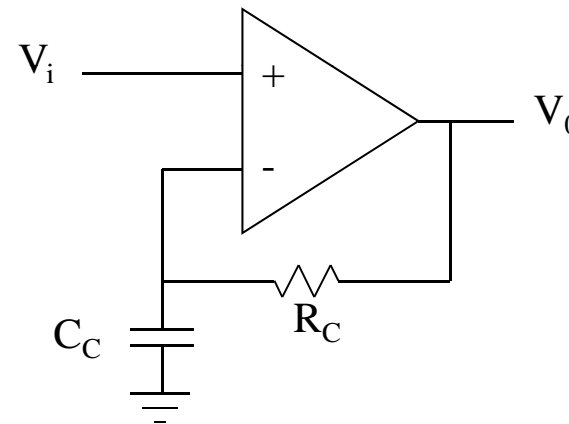
DC gain (10^4 - 10^6) V/V) :

- Very difficult to measure in open-loop due to DC offsets.



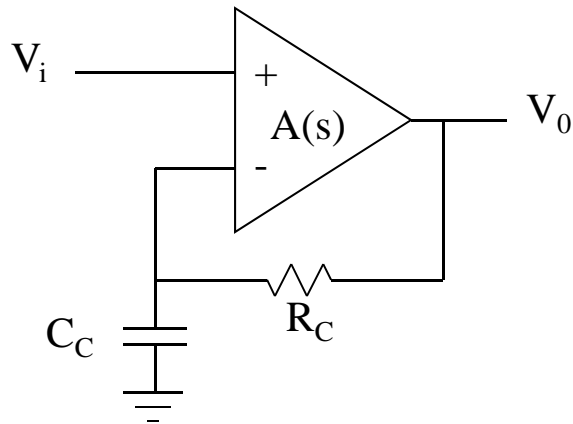
How to measure/characterize it?

- Stabilize for DC



- For DC, the OPAMP operates in closed loop!!
- For frequencies higher than $1/R_C C_C$, the OPAMP operates in open-loop with a grounded load given by R_C .

OPAMP: DC Characterization



How to measure/characterize it?

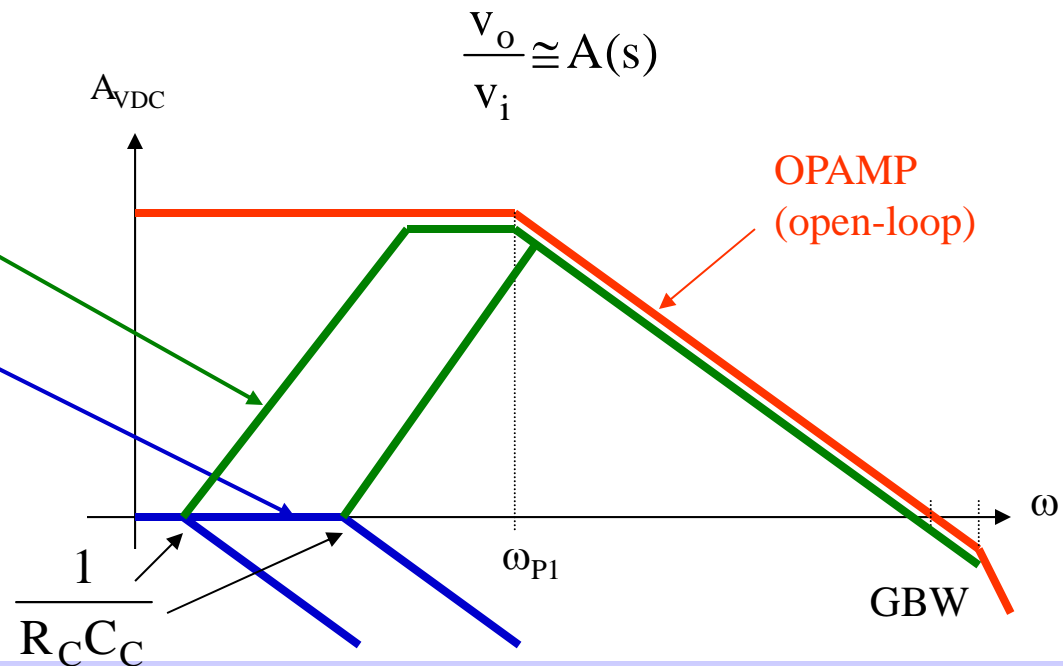
•At DC
$$\frac{v_o}{v_i} = \frac{A(s)}{1+A(s)} \cong 1$$

•If $A(s)B(s) \ll 1$ then the measured gain is dominated by the OPAMP transfer function!

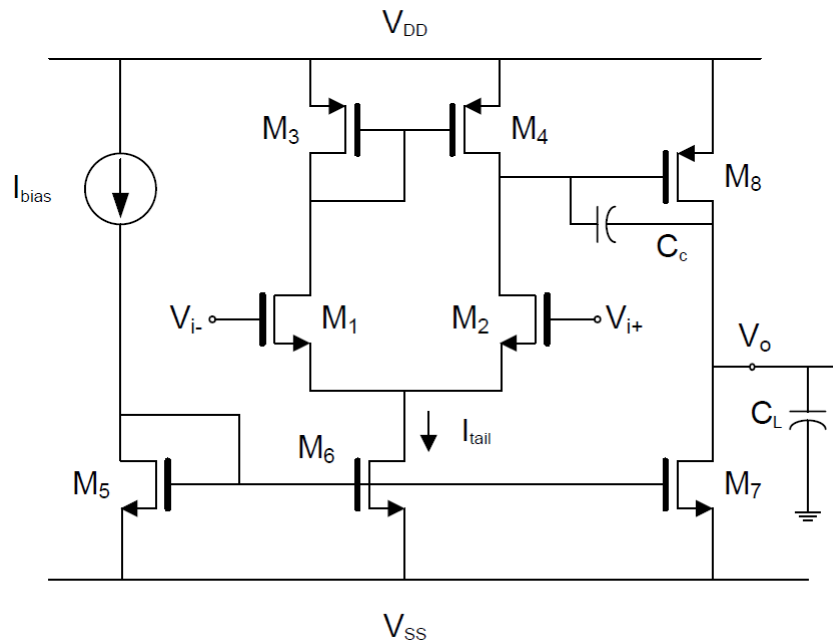
$$\frac{v_o}{v_i} = \frac{A(s)}{1+A(s)B(s)}$$

$$B(s) = \frac{1}{R_C + \frac{1}{sC_C}} = \frac{1}{1+sR_C C_C}$$

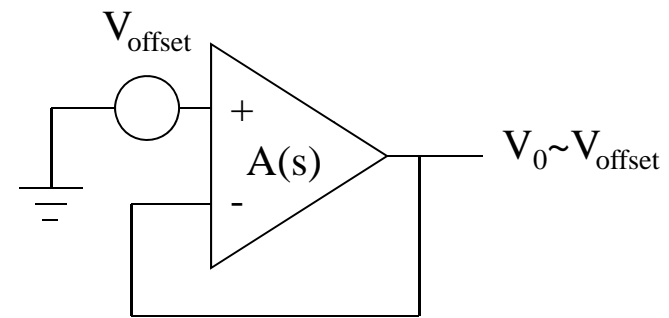
$$\omega_{PI} > [A_{DC}] \left[\frac{1}{R_C C_C} \right]$$



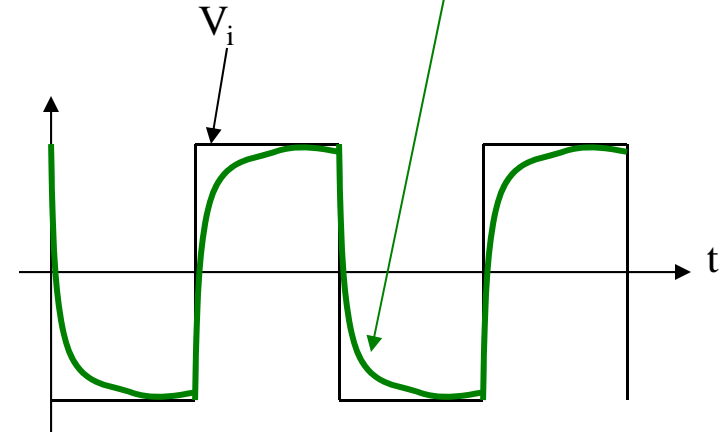
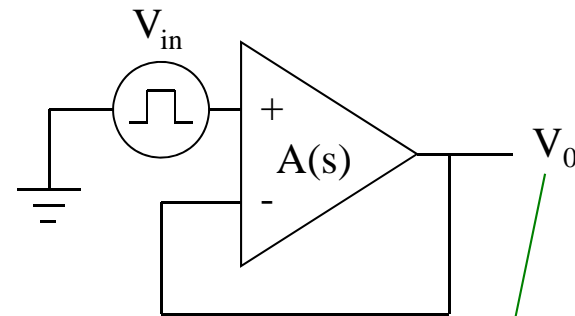
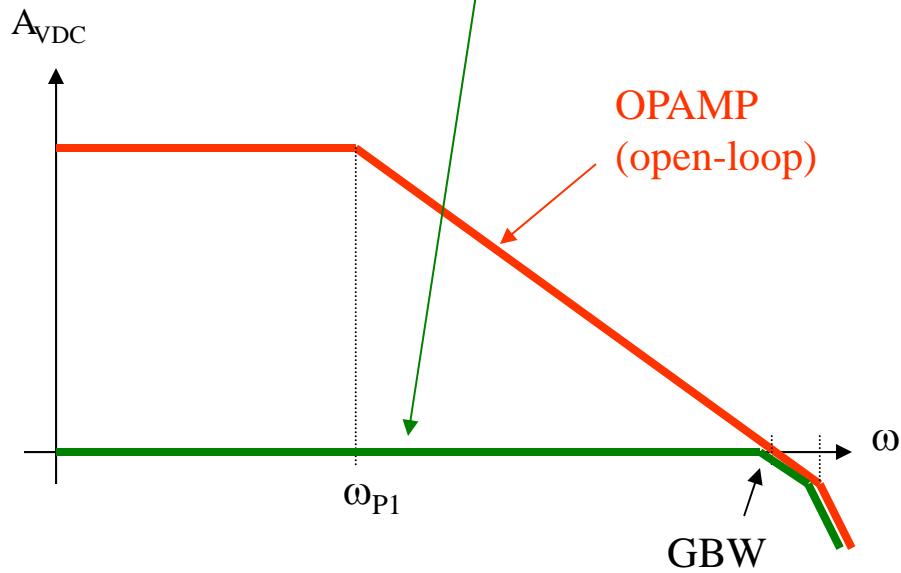
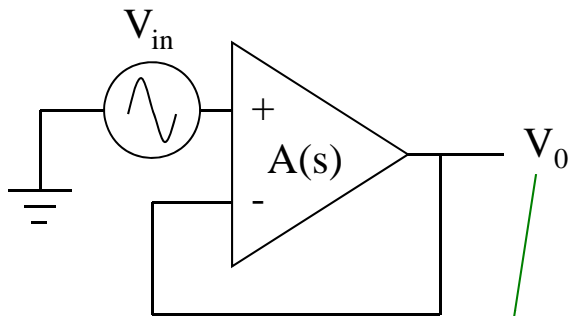
OPAMP Characterization



DC Offset

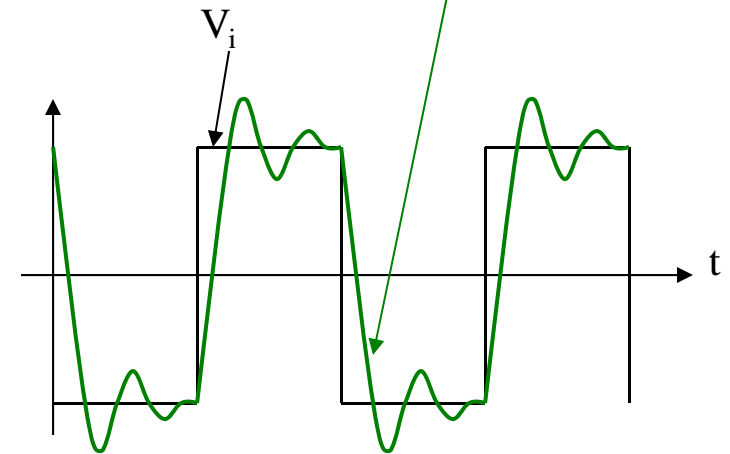
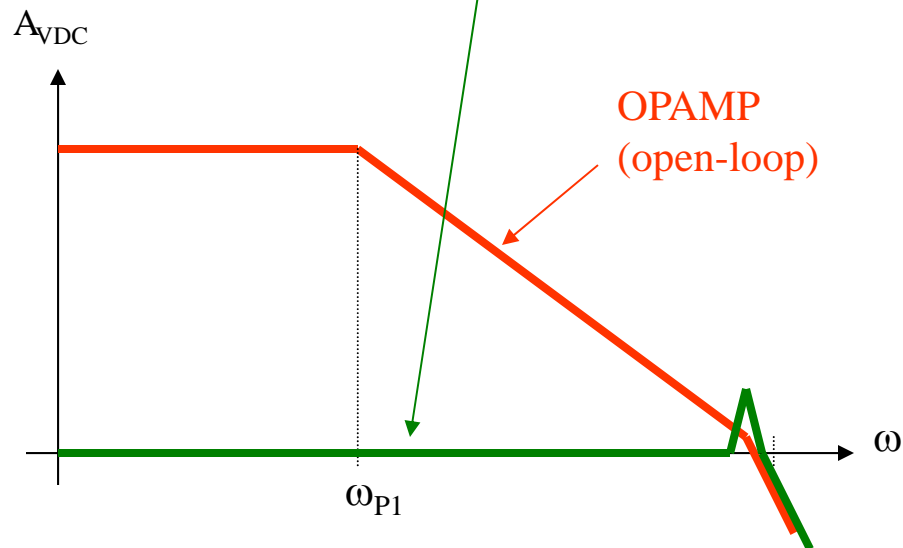
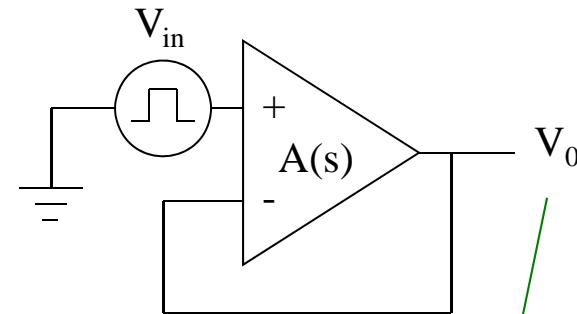
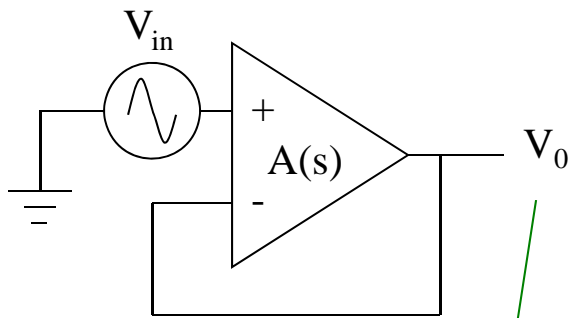


OPAMP Characterization: GBW and stability



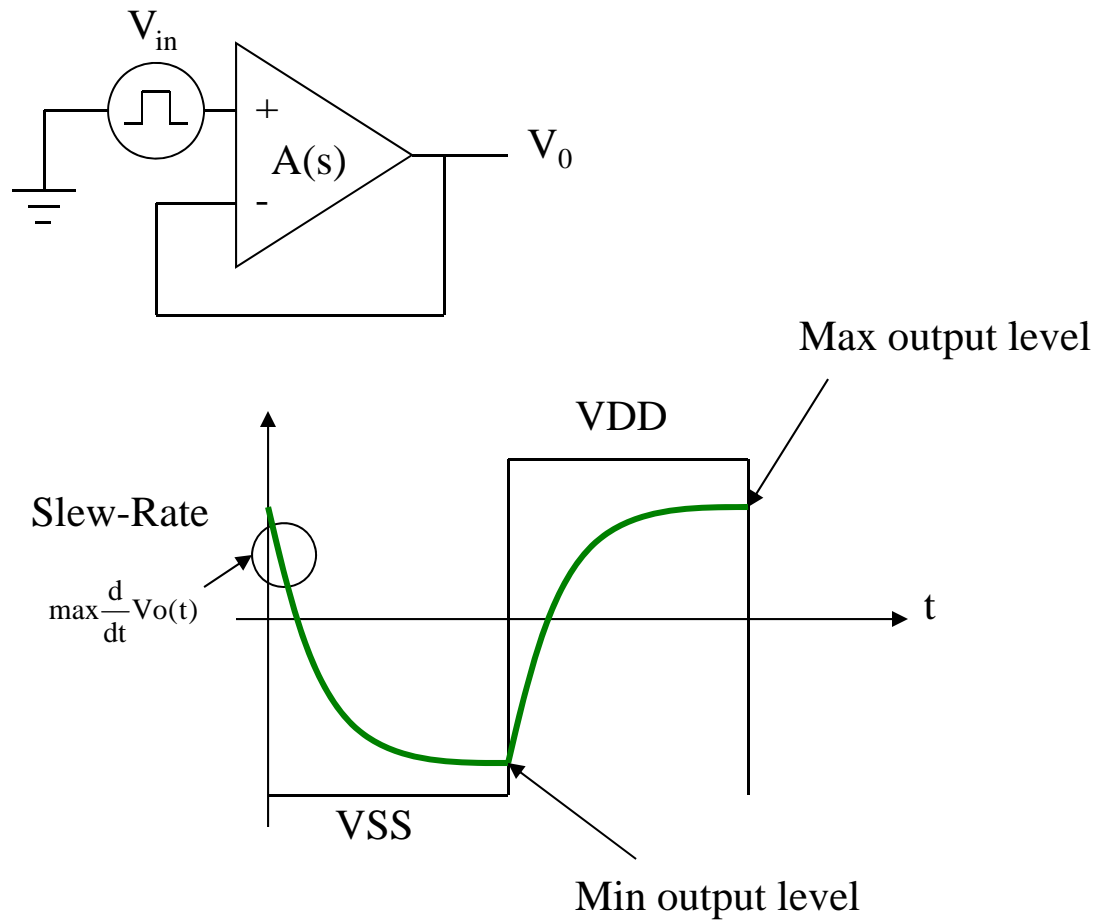
Enough phase margin

OPAMP Characterization: GBW and stability

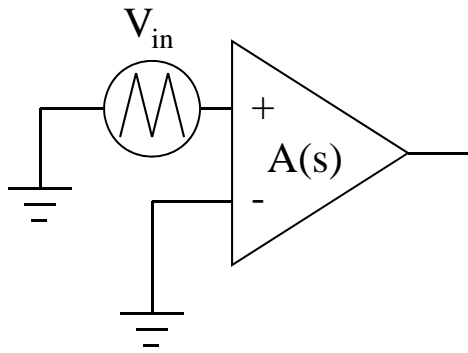


Not enough phase margin

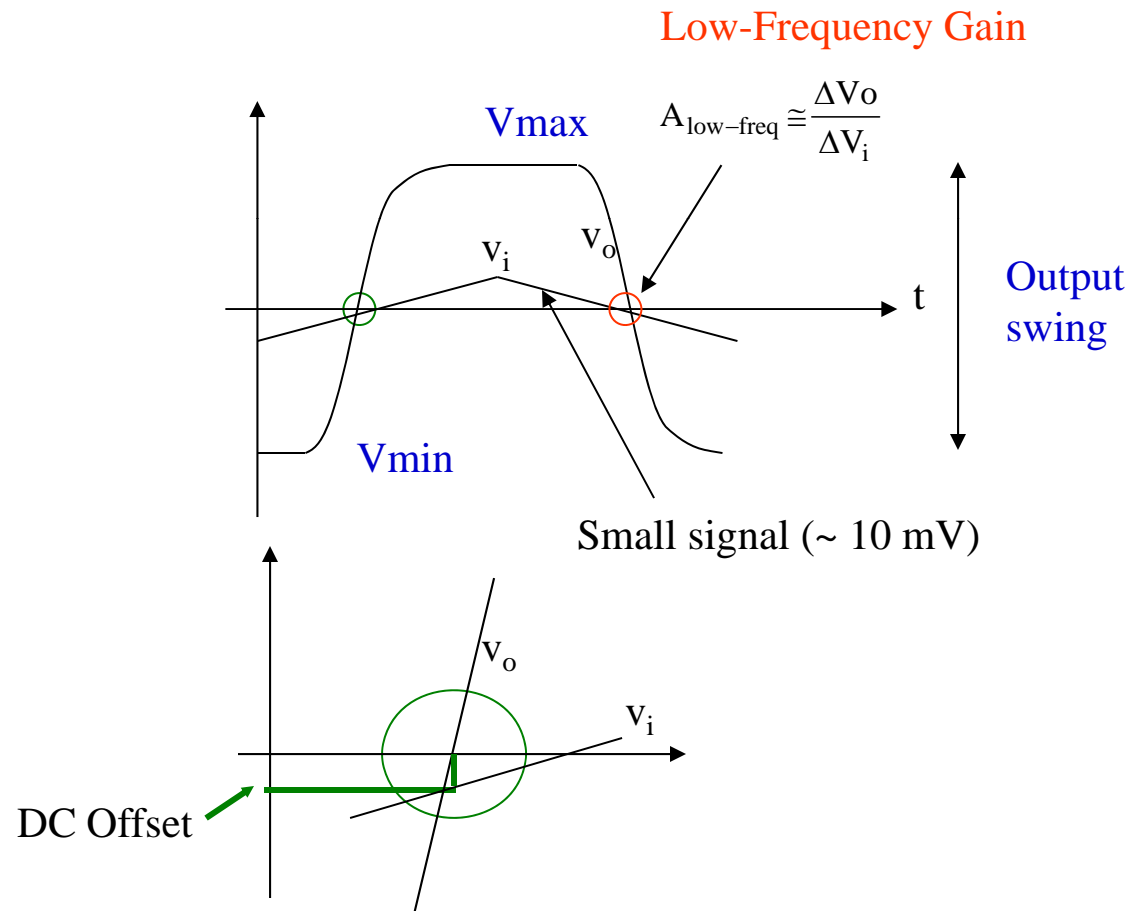
OPAMP Characterization: Slew-Rate (max speed)



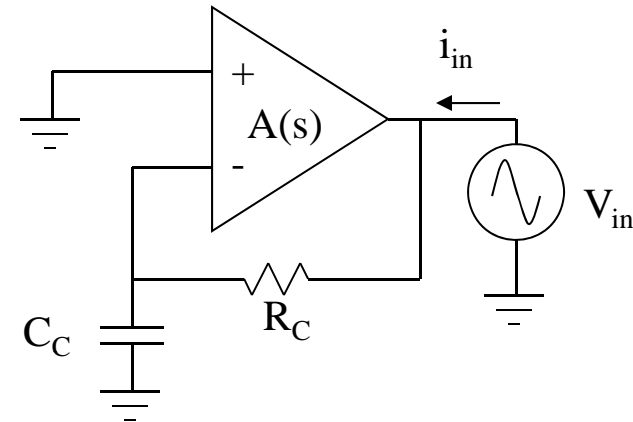
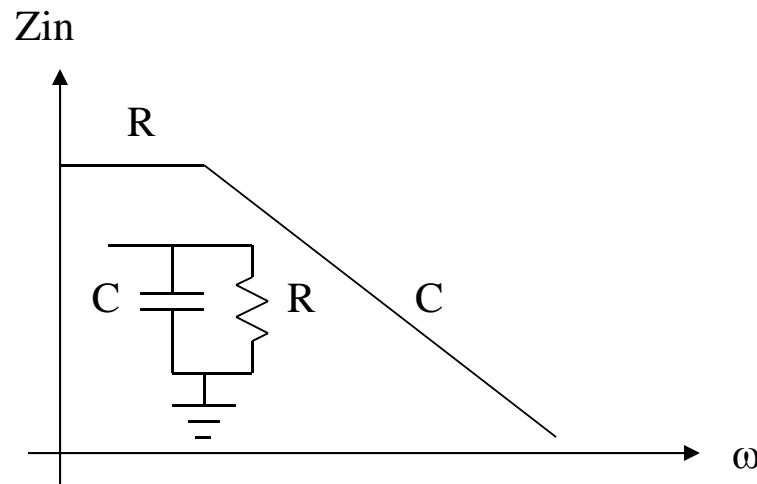
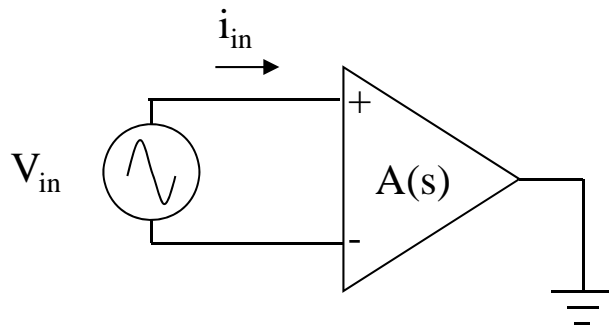
OPAMP Characterization: Output Swing



Use a slow triangular input signal such that the raising and falling edges are not determined by slew rate limitations



OPAMP Characterization: Input and Output impedance



R_C and C_C as large as possible!!

At Low frequencies:

$$Z_{\text{measured}} \neq Z_o \text{ (Why????)}$$

At medium frequencies:

$$Z_{\text{measured}} = Z_o \parallel R_C$$

Be sure that the OPAMP (all internal transistors) is properly biased during characterization!!

Next Time

- OpAmp Feedback & Stability
- Common-Mode Feedback Techniques